

October 2008

FDY1002PZ Dual P-Channel (–1.5 V) Specified PowerTrench[®] MOSFET –20 V, –0.83 A, 0.5 Ω

Features

- Max $r_{DS(on)} = 0.5 \Omega$ at $V_{GS} = -4.5 V$, $I_D = -0.83 A$
- Max $r_{DS(on)} = 0.7 \Omega$ at $V_{GS} = -2.5 V$, $I_D = -0.70 A$
- Max $r_{DS(on)} = 1.2 \Omega$ at $V_{GS} = -1.8 V$, $I_D = -0.43 A$
- Max $r_{DS(on)}$ = 1.8 Ω at V_{GS} = -1.5 V, I_D = -0.36 A
- HBM ESD protection level = 1400 V (Note 3)
- RoHS Compliant



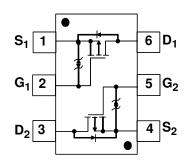
General Description

This Dual P-Channel MOSFET has been designed using Fairchild Semiconductor's advanced Power Trench process to optimize the $r_{DS(on)}@V_{GS} = -1.5$ V.

Application

Li-Ion Battery Pack





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DS}	Drain to Source Voltage		-20	V
V _{GS}	Gate to Source Voltage		±8	V
1	Drain Current -Continuous	(Note 1a)	-0.83	•
D	-Pulsed		-1.0	A
D	Power Dissipation	(Note 1a)	0.625	w
PD	Power Dissipation	(Note 1b)	0.446	vv
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1a)	200	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1b)	280	C/ W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
G	FDY1002PZ	SC89-6	7 " 8 mm		3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Chara	cteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = -250 μA, V _{GS} = 0 V	-20			V	
ΔBV_{DSS} ΔT_J	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, referenced to 25 °C		-11		mV/°C	
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = -16 V, V_{GS} = 0 V$			-1	μA	
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 8 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA	
On Chara	cteristics (Note 2)						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \ \mu A$	-0.4	-0.7	-1.0	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, referenced to 25 °C		3		mV/°C	
r _{DS(on)}	Static Drain to Source On-Resistance	$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -0.83 \text{ A}$		0.28	0.5		
		$V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -0.70 \text{ A}$		0.36	0.7	Ω	
		$V_{GS} = -1.8 \text{ V}, \text{ I}_{D} = -0.43 \text{ A}$		0.47	1.2		
		$V_{GS} = -1.5 \text{ V}, \text{ I}_{D} = -0.36 \text{ A}$		0.62	1.8		
		V _{GS} = -4.5 V, I _D = -0.83 A, T _J =125 °C		0.39	0.85	-	
9 _{FS}	Forward Transconductance	$V_{DD} = -5 \text{ V}, \text{ I}_{D} = -0.83 \text{ A}$		2		S	
Dynamic	Characteristics						
C _{iss}	Input Capacitance			100	135	pF	
C _{oss}	Output Capacitance	─ V _{DS} = −10 V, V _{GS} = 0 V, f = 1 MHz		23	35	pF	
C _{rss}	Reverse Transfer Capacitance			18	30	pF	
Switching	Characteristics (Note 2)						
t _{d(on)}	Turn-On Delay Time			3.5	10	ns	
t _r	Rise Time	V _{DD} = -10 V, I _D = -0.83 A		2.9	10	ns	
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = -4.5 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		23	37	ns	
t _f	Fall Time	1		13	23	ns	
Q _g	Total Gate Charge			2.2	3.1	nC	
Q _{gs}	Gate to Source Charge	$V_{DD} = -10 \text{ V}, I_D = -0.83 \text{ A}$		0.3		nC	
Q _{gd}	Gate to Drain "Miller" Charge	$V_{GS} = -4.5 V$		0.6		nC	
-	Irce Diode Characteristics and M	aximum Bating			<u> </u>	I	
	Maximum Continuous Drain-Source Diode	•			-0.52	А	
I _S V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{S} = -0.52 \text{ A}$ (Note 2)		-1.0	-1.2	V	
	Reverse Recovery Time			18	31	ns	
t _{rr} Q _{rr}	Reverse Recovery Charge	$I_{F} = -0.83 \text{ A}, \ dI_{F}/dt = 100 \text{ A}/\mu \text{s}$		3.8	10	nC	
Grr	neverse necevery Unarge			0.0	10		

1. R_{0,A} is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,JC} is guaranteed by design while R_{0,JA} is determined by the user's board design.

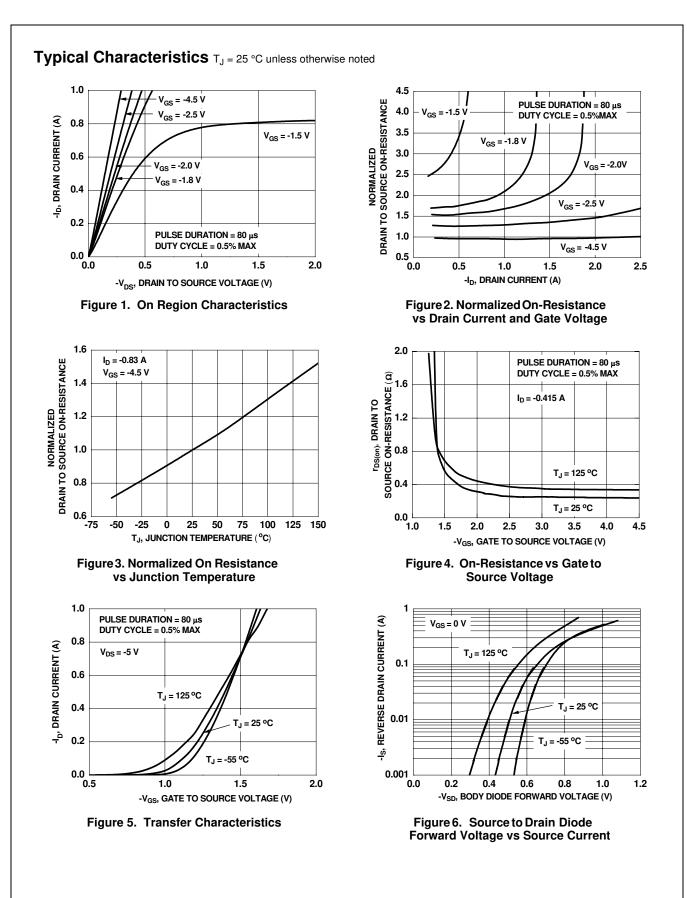


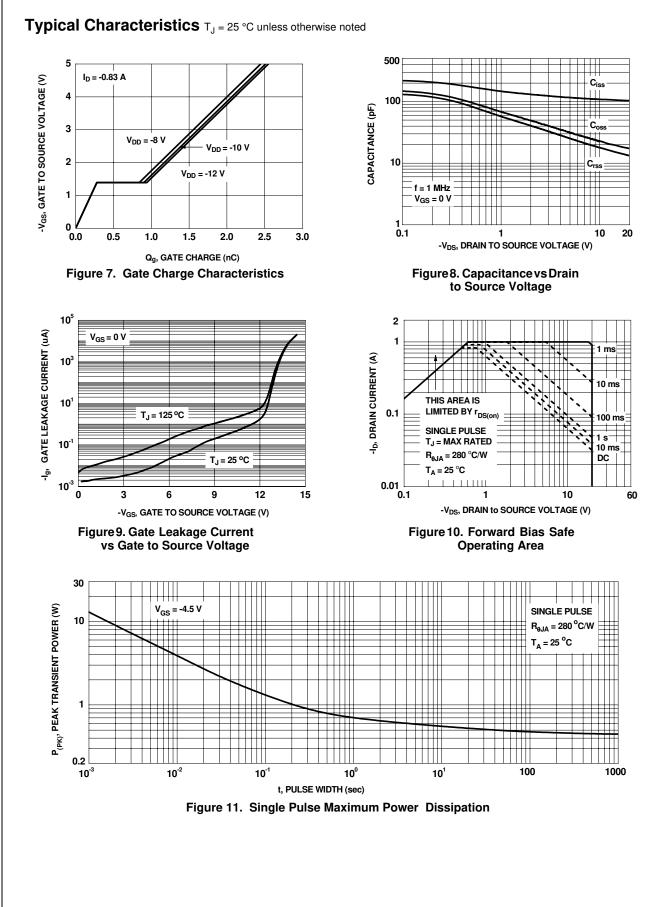
a) 200 °C/W when mounted on a 1 in² pad of 2 oz copper.

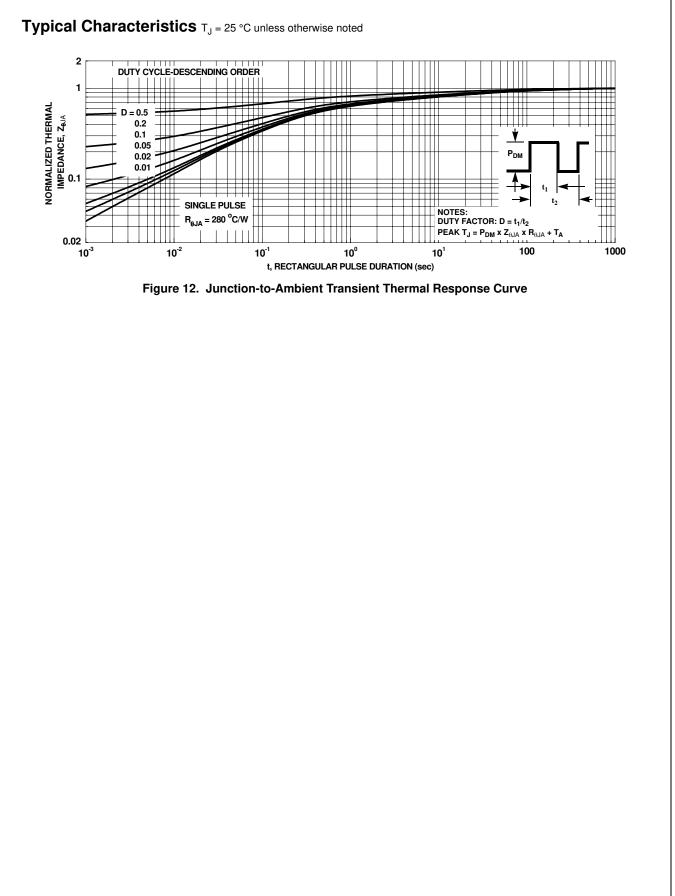
Pulse Test : Pulse Width < 300 us, Duty Cycle < 2.0%
The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

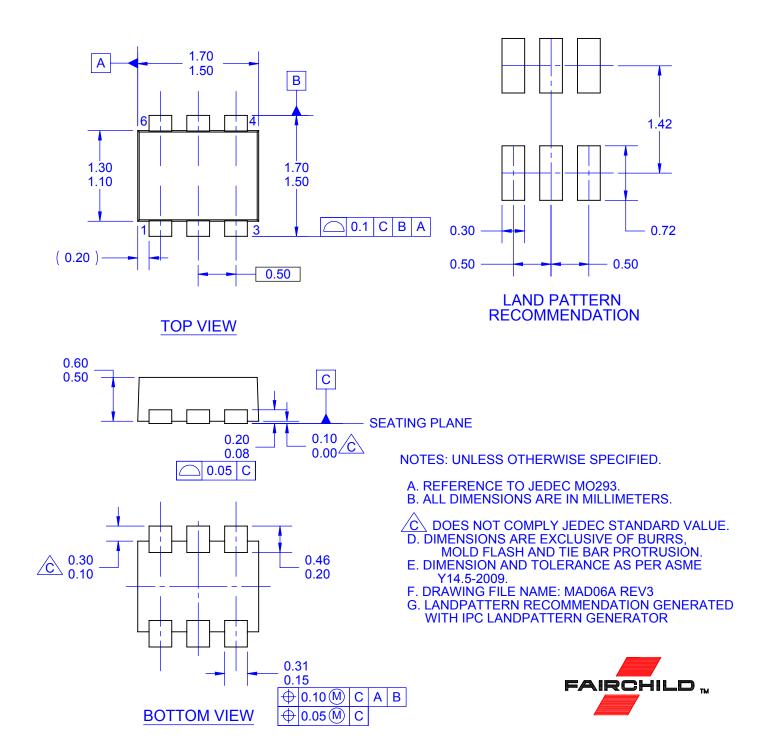
b) 280 °C/W when mounted on a minimum pad of 2 oz copper.

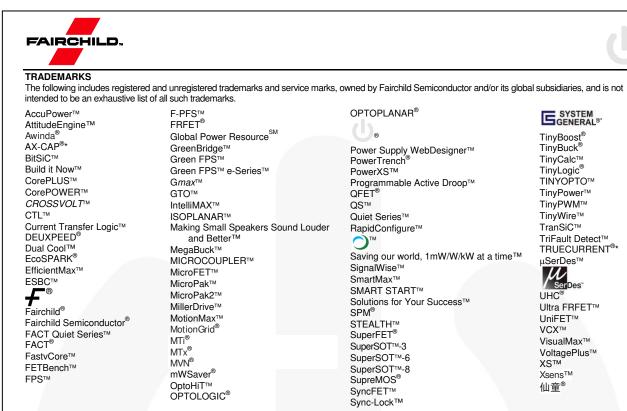












* Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. TO OBTAIN THE LATEST, MOST UP-TO-DATE DATASHEET AND PRODUCT INFORMATION, VISIT OUR WEBSITE AT <u>HTTP://WWW.FAIRCHILDSEMI.COM</u>, FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

AUTHORIZED USE

Unless otherwise specified in this data sheet, this product is a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability. This product may not be used in the following applications, unless specifically approved in writing by a Fairchild officer: (1) automotive or other transportation, (2) military/aerospace, (3) any safety critical application – including life critical medical equipment – where the failure of the Fairchild product reasonably would be expected to result in personal injury, death or property damage. Customer's use of this product is automative of this Authorized Use policy. In the event of an unauthorized use of Fairchild's product, Fairchild accepts no liability in the event of product failure. In other respects, this product shall be subject to Fairchild's Worldwide Terms and Conditions of Sale, unless a separate agreement has been signed by both Parties.

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Terms of Use

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS

Definition of Terms		
Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. 177